

**Notice of References Cited**

Application/Control No.

09/857,652

Applicant(s)/Patent Under  
Reexamination  
NONAKA ET AL.

Examiner

Shean C Wu

Art Unit

1756

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6368679 B1	04-2002	Schmidt et al.	428/1.1
	C	US-6482479 B1	11-2002	Dubal et al.	428/1.1
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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